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Application/Control No.	Applicant(s)/Patent under Reexamination
10/645,578	OGUSHI ET AL.
Examiner	Art Unit
Huan H. Tran	2861

SEARCHED					
Class	Subclass	Date	Examiner		
347	222	4/29/2005	ннт		
347	263	4/29/2005	ННТ		
347	108	4/29/2005	ННТ		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
222	4/29/2005	ннт			
263	4/29/2005	ННТ			
	Subclass 222	Subclass Date   222 4/29/2005			

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
EAST	4/29/2005	ннт
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